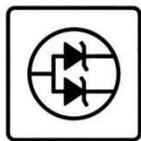


MSKSEMI 美森科

SEMICONDUCTOR



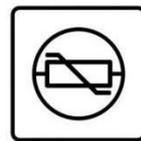
ESD



TVS



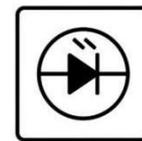
TSS



MOV



GDT



PLED

ESD9N5V-2-MS

Product specification

Feature

- 100W peak pulse power per line (tP =8/20μs)
- DFN1006-2L package
- Replacement for MLV(0402)
- Unidirectional configurations
- Response time is typically < 1 ns
- Protect one I/O or power line
- Low clamping voltage
- RoHS compliant
- Transient protection for data lines to
- IEC 61000-4-2(ESD) ±30KV(air), ±30KV(contact);
IEC 61000-4-4 (EFT) 40A (5/50ns)

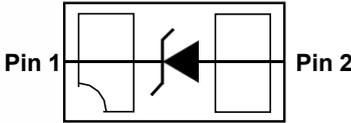
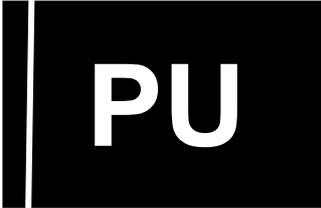
Applications

- Cell phone handsets and accessories
- Personal digital assistants (PDA's)
- Notebooks, desktops, and servers
- Portable instrumentation
- Cordless phones
- Digital cameras
- Peripherals
- MP3 players

Mechanical Characteristics

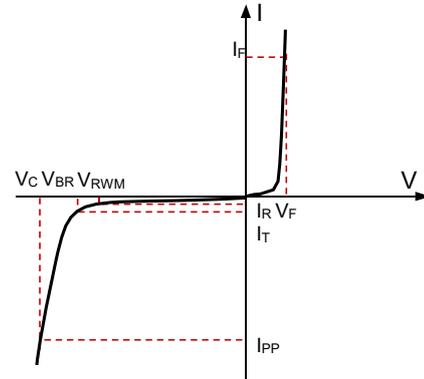
- Mounting position: Any
- Qualified max reflow temperature:260°C
- Device meets MSL 1 requirements
- DFN1006-2L without plating

Reference News

PACKAGE OUTLINE	Circuit Diagram	Marking
 <p data-bbox="221 1666 376 1695">DFN1006-2L</p>		

Electronics Parameter

Symbol	Parameter
V_{RWM}	Peak Reverse Working Voltage
I_R	Reverse Leakage Current @ V_{RWM}
V_{BR}	Breakdown Voltage @ I_T
I_T	Test Current
I_{PP}	Maximum Reverse Peak Pulse Current
V_C	Clamping Voltage @ I_{PP}
P_{PP}	Peak Pulse Power
C_J	Junction Capacitance
I_F	Forward Current
V_F	Forward Voltage @ I_F


Electrical characteristics per line@25°C (unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Units
Working Voltage	V_{RWM}				5	V
Breakdown Voltage	V_{BR}	$I_T = 1\text{mA}$	6	6.8	7.2	V
Reverse Leakage Current	I_R	$V_{RWM} = 5\text{V}$			1	μA
Forward Voltage	V_F	$I_F = 10\text{mA}$		0.8		V
Clamping Voltage	V_C	$I_{PP} = 1\text{A } t_P = 8/20\mu\text{s}$			9.0	V
Clamping Voltage	V_C	$I_{PP} = 5\text{A } t_P = 8/20\mu\text{s}$			11.0	V
Junction Capacitance	C_J	$V_R = 0\text{V } f = 1\text{MHz}$		30	40	pF
Junction Capacitance	C_J	$V_R = 2.5\text{V } f = 1\text{MHz}$		22	30	pF

Absolute maximum rating@25°C

Rating	Symbol	Value	Units
Peak Pulse Power ($t_P = 8/20\mu\text{s}$)	P_{PP}	100	W
Lead Soldering Temperature	T_L	260 (10 sec)	$^{\circ}\text{C}$
Operating Temperature	T_J	-55 to 125	$^{\circ}\text{C}$
Storage Temperature	T_{STG}	-55 to 150	$^{\circ}\text{C}$

Typical Characteristics

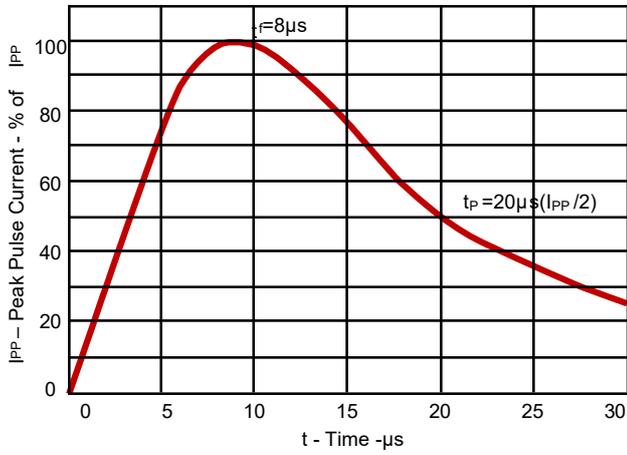


Fig 1. Pulse Waveform

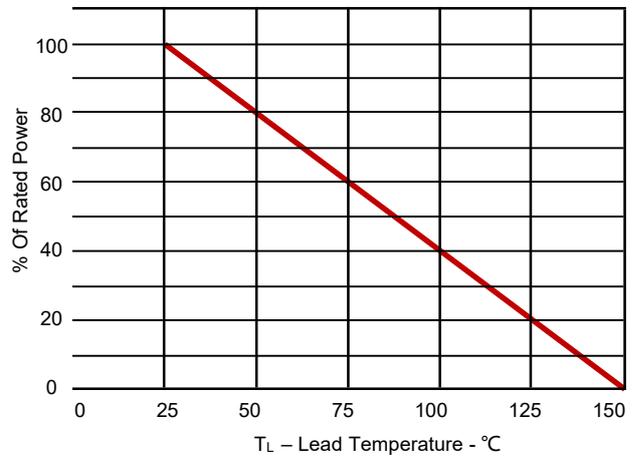


Fig 2. Power Derating Curve

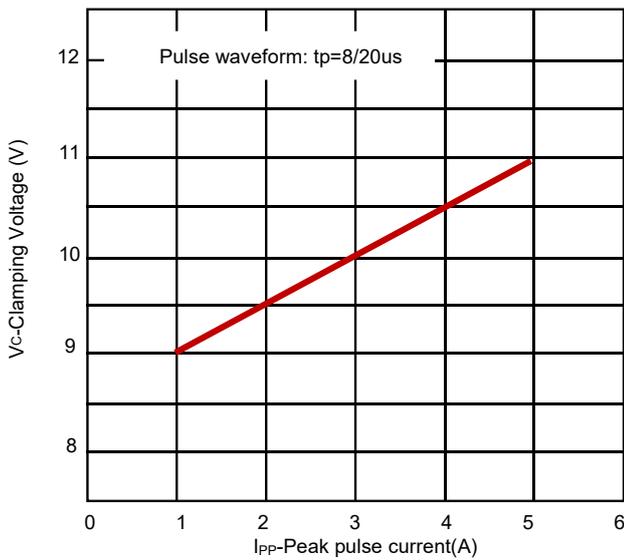


Fig 3. Clamping voltage vs. Peak pulse current

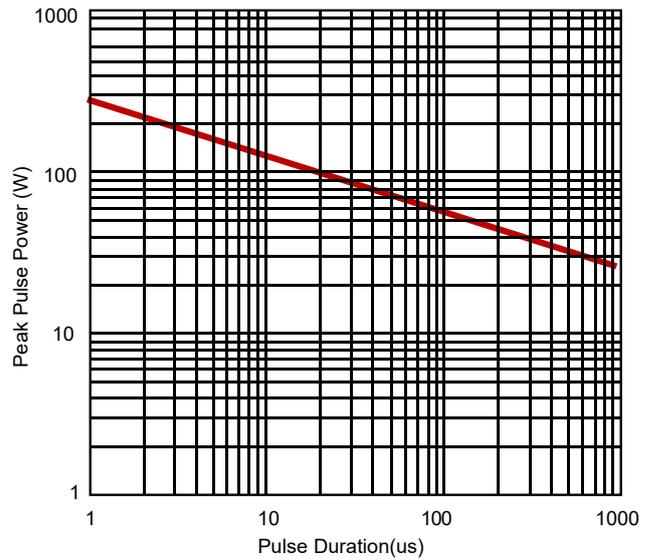
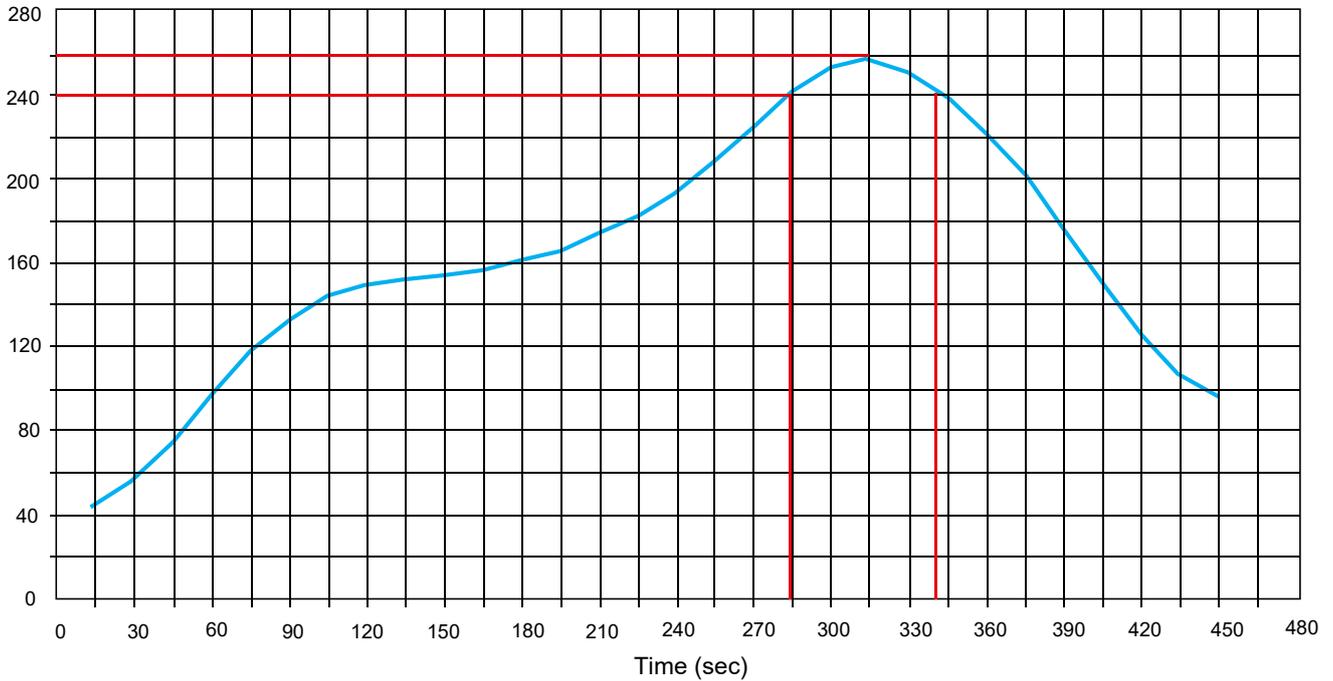


Fig 4. Non Repetitive Peak Pulse Power vs. Pulse time

Solder Reflow Recommendation

Peak Temp=257°C, Ramp Rate=0.802deg. °C/sec

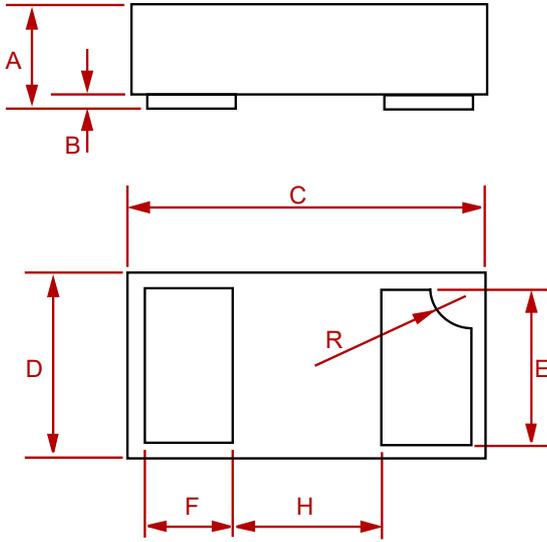


PCB Design

For TVS diodes a low-ohmic and low-inductive path to chassis earth is absolutely mandatory in order to achieve good ESD protection. Novices in the area of ESD protection should take following suggestions to heart:

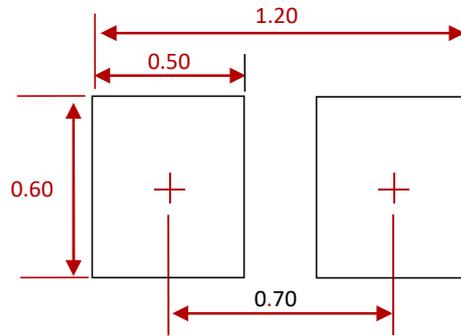
- Do not use stubs, but place the cathode of the TVS diode directly on the signal trace.
- Do not make false economies and save copper for the ground connection.
- Place via holes to ground as close as possible to the anode of the TVS diode.
- Use as many via holes as possible for the ground connection.
- Keep the length of via holes in mind! The longer the more inductance they will have.

PACKAGE MECHANICAL DATA



Dim	Inches		Millimeters	
	MIN	MAX	MIN	MAX
A	0.0125	0.02	0.32	0.52
B	0.000	0.002	0.00	0.05
C	0.037	0.043	0.95	1.080
D	0.022	0.027	0.55	0.680
E	0.016	0.024	0.40	0.60
F	0.008	0.012	0.20	0.30
H	0.015Typ.		0.40Typ.	
R	0.001	0.005	0.05	0.15

Suggested Pad Layout



NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).
2. THIS LAND PATTERN IS FOR REFERENCE PURPOSES ONLY. CONSULT YOUR MANUFACTURING GROUP TO ENSURE YOUR COMPANY'S MANUFACTURING GUIDELINES ARE MET.

REEL SPECIFICATION

P/N	PKG	QTY
ESD9N5V-2-MS	DFN1006-2L	10000

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